

## Search Notes



**Application/Control No.**

10/718,064

**Examiner**

Ellen C. Tran

**Applicant(s)/Patent under  
Reexamination**

FERRI ET AL.

## Art Unit

2134

**SEARCHED**

**SEARCHED**

**INTERFERENCE SEARCHED**

<b>INTERFERENCE SEARCHED</b>			
Class	Subclass	Date	Examiner

## **SEARCH NOTES (INCLUDING SEARCH STRATEGY)**

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
USPTO, USPG, EPO, JPO, DERWENT, IBM TECH DES	5/23/2007	ECT
NPL - IEEE XPLORER	5/23/2007	ECT
INVENTOR - PALM/dDAN	5/23/2007	ECT
All claims were reviewed for possible 101 rejections	5/23/2007	ECT